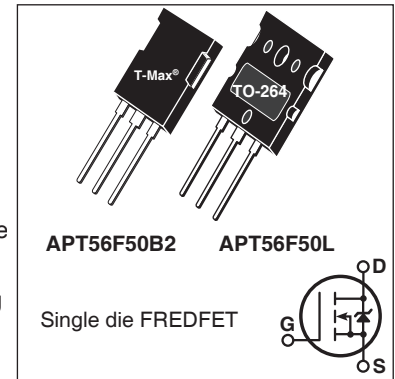



## N-Channel FREDFET

Power MOS 8™ is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced  $t_{rr}$ , soft recovery, and high recovery  $dv/dt$  capability. Low gate charge, high gain, and a greatly reduced ratio of  $C_{rSS}/C_{iSS}$  result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control  $di/dt$  during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



### FEATURES

- Fast switching with low EMI
- Low  $t_{rr}$  for high reliability
- Ultra low  $C_{rSS}$  for improved noise immunity
- Low gate charge
- Avalanche energy rated
- RoHS compliant 

### TYPICAL APPLICATIONS

- ZVS phase shifted and other full bridge
- Half bridge
- PFC and other boost converter
- Buck converter
- Single and two switch forward
- Flyback

### Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
$I_D$	Continuous Drain Current @ $T_C = 25^\circ\text{C}$	56	A
	Continuous Drain Current @ $T_C = 100^\circ\text{C}$	35	
$I_{DM}$	Pulsed Drain Current <sup>①</sup>	175	
$V_{GS}$	Gate-Source Voltage	±30	V
$E_{AS}$	Single Pulse Avalanche Energy <sup>②</sup>	1200	mJ
$I_{AR}$	Avalanche Current, Repetitive or Non-Repetitive	28	A

### Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Typ	Max	Unit
$P_D$	Total Power Dissipation @ $T_C = 25^\circ\text{C}$			780	W
$R_{\theta JC}$	Junction to Case Thermal Resistance			0.16	°C/W
$R_{\theta CS}$	Case to Sink Thermal Resistance, Flat, Greased Surface		0.11		
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55		150	°C
$T_L$	Soldering Temperature for 10 Seconds (1.6mm from case)			300	
$W_T$	Package Weight		0.22		oz
			6.2		g
Torque	Mounting Torque ( TO-264 Package), 4-40 or M3 screw			10	in·lbf
				1.1	N·m

**Static Characteristics**
**T<sub>J</sub> = 25°C unless otherwise specified**
**APT56F50B2\_L**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V <sub>BR(DSS)</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	500			V
ΔV <sub>BR(DSS)/ΔT<sub>J</sub></sub>	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I <sub>D</sub> = 250μA		0.60		V/°C
R <sub>DS(on)</sub>	Drain-Source On Resistance <sup>③</sup>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 28A		0.085	0.10	Ω
V <sub>GS(th)</sub>	Gate-Source Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 2.5mA	3	4	5	V
ΔV <sub>GS(th)/ΔT<sub>J</sub></sub>	Threshold Voltage Temperature Coefficient			-10		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 500V V <sub>GS</sub> = 0V			250	μA
		T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C			1000	
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> = ±30V			±100	nA

**Dynamic Characteristics**
**T<sub>J</sub> = 25°C unless otherwise specified**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> = 50V, I <sub>D</sub> = 28A		43		S
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V f = 1MHz		8800		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			120		
C <sub>oss</sub>	Output Capacitance			945		
C <sub>o(er)</sub> <sup>④</sup>	Effective Output Capacitance, Charge Related	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 333V		550		
C <sub>o(er)</sub> <sup>⑤</sup>	Effective Output Capacitance, Energy Related			275		
Q <sub>g</sub>	Total Gate Charge	V <sub>GS</sub> = 0 to 10V, I <sub>D</sub> = 28A, V <sub>DS</sub> = 250V		220		nC
Q <sub>gs</sub>	Gate-Source Charge			50		
Q <sub>gd</sub>	Gate-Drain Charge			100		
t <sub>d(on)</sub>	Turn-On Delay Time	<b>Resistive Switching</b> V <sub>DD</sub> = 333V, I <sub>D</sub> = 28A R <sub>G</sub> = 4.7Ω <sup>⑥</sup> , V <sub>GG</sub> = 15V		38		ns
t <sub>r</sub>	Current Rise Time			45		
t <sub>d(off)</sub>	Turn-Off Delay Time			100		
t <sub>f</sub>	Current Fall Time			33		

**Source-Drain Diode Characteristics**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
I <sub>S</sub>	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n junction diode (body diode)			38	A
I <sub>SM</sub>	Pulsed Source Current (Body Diode) <sup>①</sup>				175	
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> = 28A, T <sub>J</sub> = 25°C, V <sub>GS</sub> = 0V			1.0	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>SD</sub> = 28A <sup>③</sup> di <sub>SD</sub> /dt = 100A/μs V <sub>DD</sub> = 100V	T <sub>J</sub> = 25°C		280	ns
			T <sub>J</sub> = 125°C		520	
Q <sub>rr</sub>	Reverse Recovery Charge		T <sub>J</sub> = 25°C	1.20		μC
			T <sub>J</sub> = 125°C	3.07		
I <sub>rrm</sub>	Reverse Recovery Current		T <sub>J</sub> = 25°C	10.1		A
		T <sub>J</sub> = 125°C	14.5			
dv/dt	Peak Recovery dv/dt	I <sub>SD</sub> ≤ 28A, di/dt ≤ 1000A/μs, V <sub>DD</sub> = 333V, T <sub>J</sub> = 125°C			20	V/ns

① Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.

② Starting at T<sub>J</sub> = 25°C, L = 3.06mH, R<sub>G</sub> = 4.7Ω, I<sub>AS</sub> = 28A.

③ Pulse test: Pulse Width < 380μs, duty cycle < 2%.

④ C<sub>o(er)</sub> is defined as a fixed capacitance with the same stored charge as C<sub>OSS</sub> with V<sub>DS</sub> = 67% of V<sub>(BR)DSS</sub>.

⑤ C<sub>o(er)</sub> is defined as a fixed capacitance with the same stored energy as C<sub>OSS</sub> with V<sub>DS</sub> = 67% of V<sub>(BR)DSS</sub>. To calculate C<sub>o(er)</sub> for any value of V<sub>DS</sub> less than V<sub>(BR)DSS</sub>, use this equation: C<sub>o(er)</sub> = -2.04E-7/V<sub>DS</sub><sup>2</sup> + 4.76E-8/V<sub>DS</sub> + 1.36E-10.

⑥ R<sub>G</sub> is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

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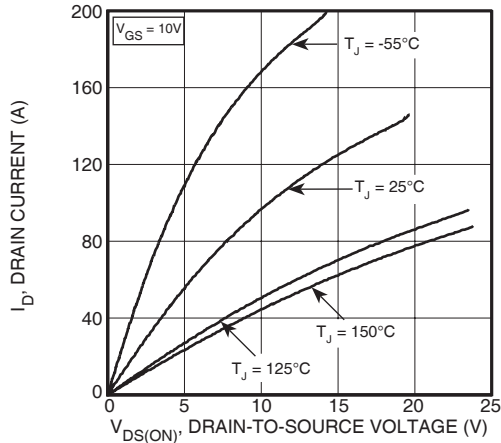


Figure 1, Output Characteristics

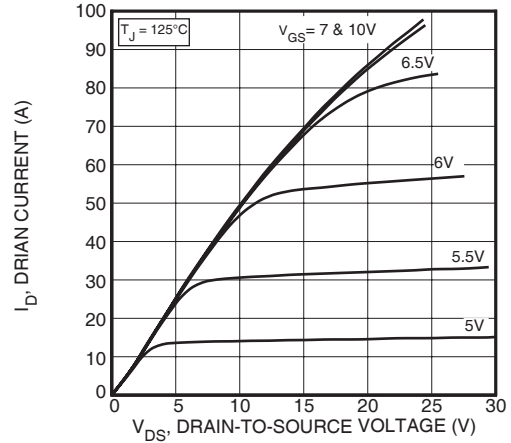


Figure 2, Output Characteristics

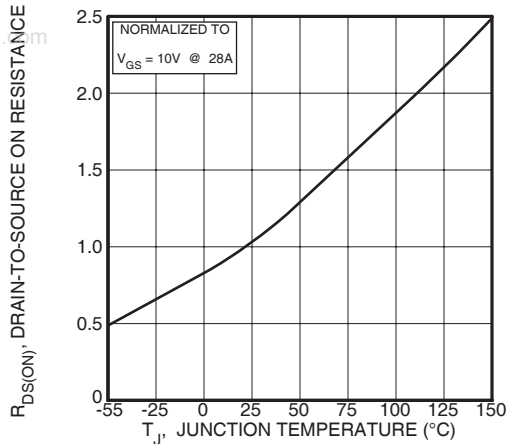


Figure 3,  $R_{DS(ON)}$  vs Junction Temperature

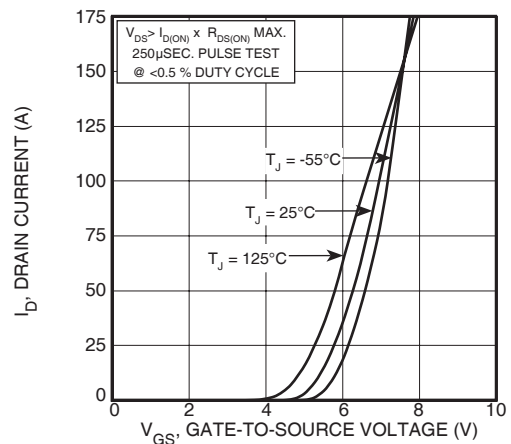


Figure 4, Transfer Characteristics

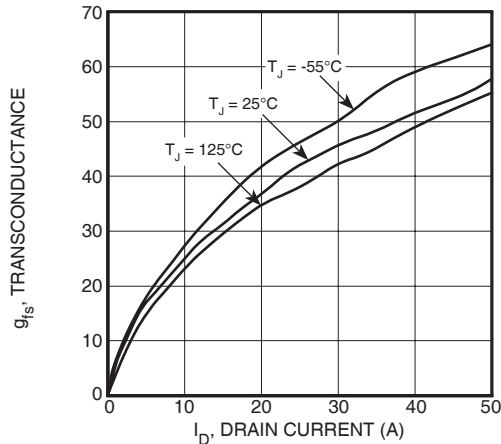


Figure 5, Gain vs Drain Current

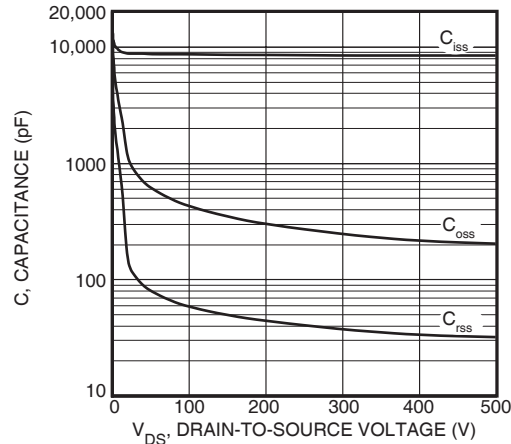


Figure 6, Capacitance vs Drain-to-Source Voltage

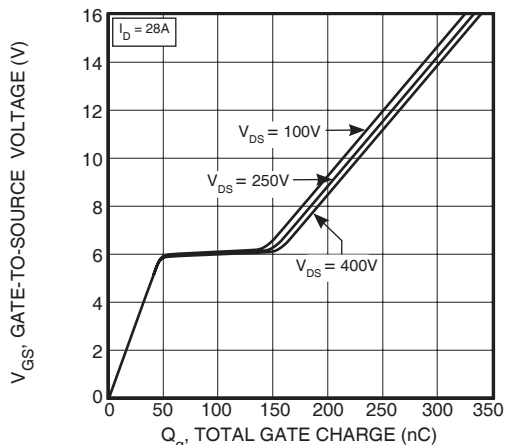


Figure 7, Gate Charge vs Gate-to-Source Voltage

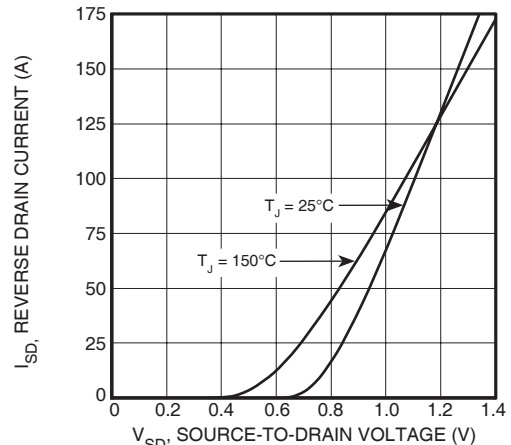
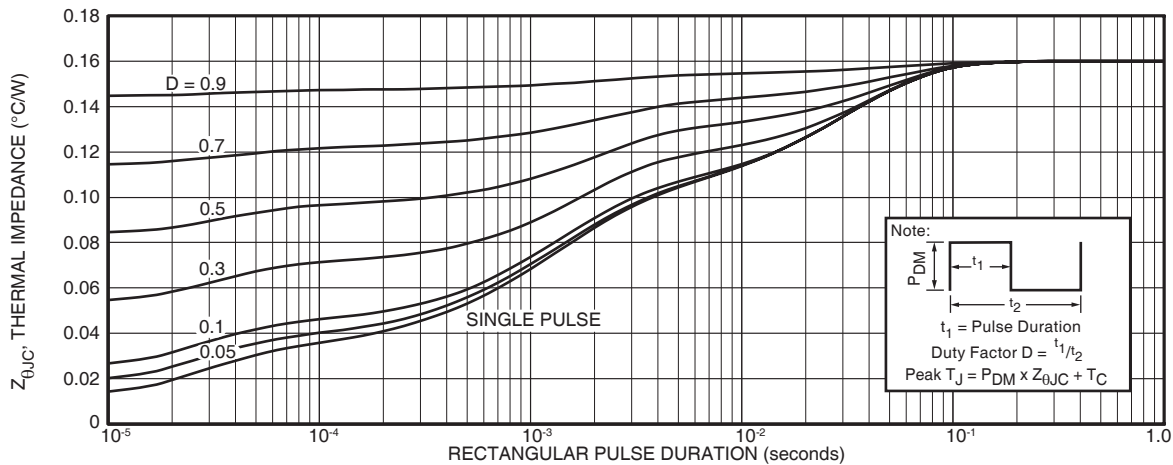
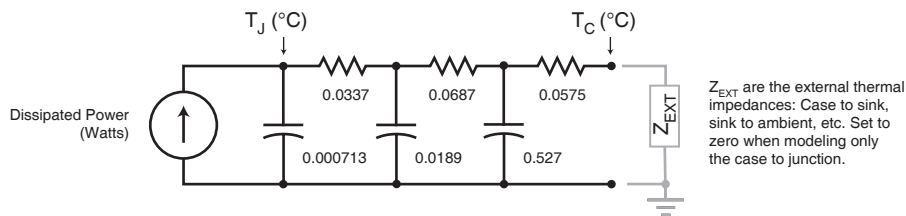
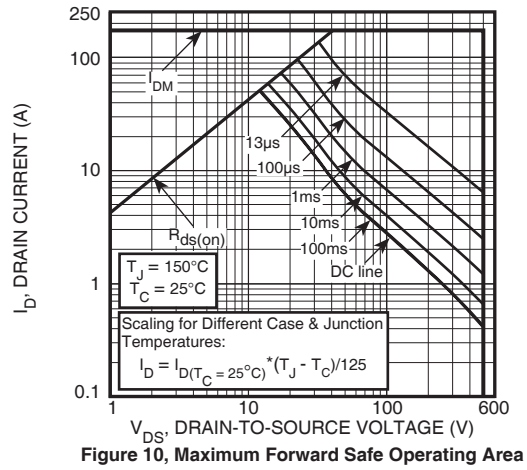
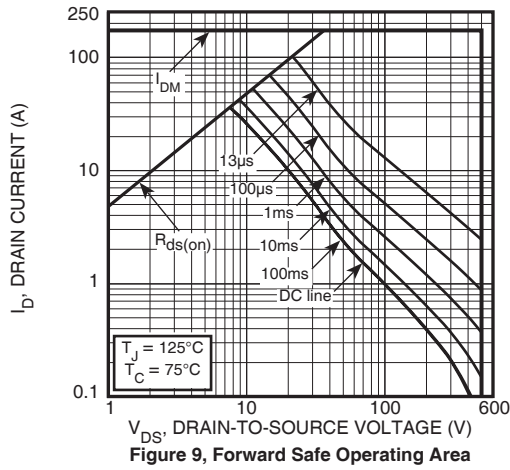
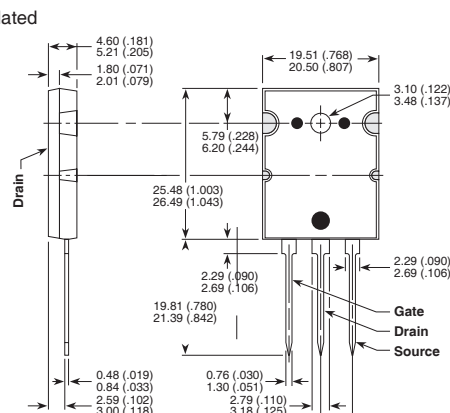
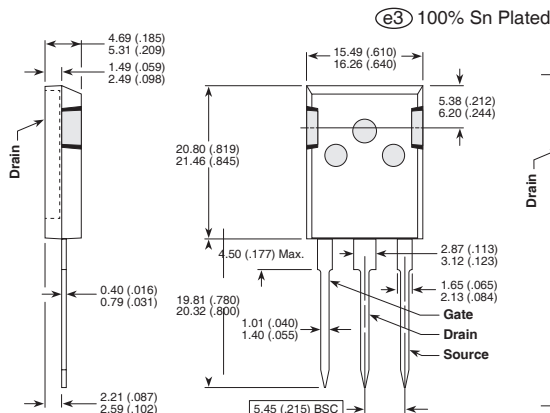


Figure 8, Reverse Drain Current vs Source-to-Drain Voltage



**T-MAX® (B2) Package Outline**

**TO-264 (L) Package Outline**



These dimensions are equal to the TO-247 without the mounting hole.  
Dimensions in Millimeters and (Inches)

Dimensions in Millimeters and (Inches)